Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10569714	MEYER ET AL.
Examiner	Art Unit
Chen, Catheryne	1655

SEARCHED				
Class		Subclass	Date	Examiner
none	none		1/22/08	CC

SEARCH NOTES				
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INVENTOR NAME, USPT, PGPB, JPAB, EPAB, DWPI, MEDLINE, EMBASE, BIOSIS, CAPLUS, REGISTRY	1/22/08	CC		

INTERFERENCE SEARCH				
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